Power MOSFET and Schottky Diode

20 V, 3.9 A, N–Channel, with 3.7 A Schottky Barrier Diode, ChipFET[™]

Features

- Leadless SMD Package Featuring a MOSFET and Schottky Diode
- 40% Smaller than TSOP-6 Package with Better Thermals
- Super Low Gate Charge MOSFET
- Ultra Low V_F Schottky
- Pb–Free Package is Available

Applications

- Fast Switching, low Gate Charge for DC-to-DC Buck and Boost Converters
- Li–Ion Battery Applications in Cell Phones, PDAs, DSCs, and Media Players
- Load Side Switching

MOSFET MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter			Symbol	Value	Unit		
Drain-to-Source Voltage			V _{DSS}	20	V		
Gate-to-Source Voltage			V _{GS}	±12	V		
Continuous Drain	Steady	$T_J = 25^{\circ}C$	Ι _D	2.9	А		
Current	State	$T_J = 85^{\circ}C$		2.1			
	$t \le 5 s$	$T_J = 25^{\circ}C$	1	3.9			
Pulsed Drain Current	t _p =	10 μs	I _{DM}	12	А		
Power Dissipation	Steady	$T_J = 25^{\circ}C$	PD	0.91	W		
	State	$T_J = 85^{\circ}C$		0.36			
$t \le 5 s$ $T_J = 25$		$T_J = 25^{\circ}C$	1	2.1			
Continuous Source Current (Body Diode)			۱ _S	2.6	А		
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to 150	°C		
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C		

SCHOTTKY DIODE MAXIMUM RATINGS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

Parameter			Symbol	Value	Unit
Peak Repetitive Reverse Voltage			V _{RRM}	20	V
DC Blocking Voltage			V _R	20	V
Average Rectified Forward Current	Steady State $T_J = 25^{\circ}C$		١ _F	2.2	A
	$t \le 5 s$			3.7	А

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

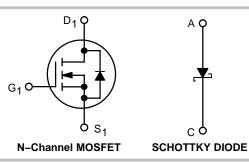


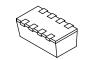
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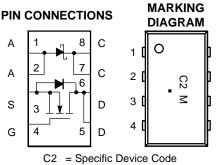
MOSFET					
V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX			
20 V	60 mΩ @ 4.5 V	3.9 A			
	80 mΩ @ 2.5 V	5.5 K			
SCHOTTKY DIODE					

V _R MAX	V _F TYP	I _F MAX
20 V	0.35 V	3.7 A









M = Month Code

= Pb–Free Package

ORDERING INFORMATION

Device	Package	Shipping [†]
NTHD4N02FT1	ChipFET	3000/Tape & Reel
NTHD4N02FT1G	ChipFET (Pb–Free)	3000/Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{ hetaJA}$	110	°C/W
Junction-to-Ambient – $t \le 5 s$	$R_{ hetaJA}$	60	°C/W

1. Surface Mounted on FR4 Board using 1 in sq. pad size (Cu area = 1.27 in sq. [1 oz] including traces).

MOSFET ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Units
OFF CHARACTERISTICS				-	-	-	-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 V$, $I_{D} = 250 \mu A$		20	28		V
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$	$T_J = 25^{\circ}C$			1.0	μΑ
		V _{DS} = 16 V	$T_J = 85^{\circ}C$			5.0	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{G}$	_S = ± 12 V			±100	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{E}$	₀ = 250 μA	0.6		1.2	V
Drain-to-Source On-Resistance	R _{DS(on)}	V _{GS} = 4.5, I	_D = 2.9 A		0.058	0.080	Ω
		V _{GS} = 2.5, I	_D = 2.3 A		0.077	0.115	
Forward Transconductance	9fs	V _{DS} = 10 V,	_D = 2.9 A		6.0		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				180	300	pF
Output Capacitance	C _{OSS}	$V_{GS} = 0 V, f = 1.0 MHz, V_{DS} = 10 V$			80	130	
Reverse Transfer Capacitance	C _{RSS}				30	50	
Total Gate Charge	Q _{G(TOT)}				2.6	4.0	nC
Gate-to-Source Charge	Q _{GS}	V _{GS} = 4.5 V, V I _D = 2.1	_{DS} = 10 V, 9 A		0.6		
Gate-to-Drain Charge	Q _{GD}	5			0.7		
SWITCHING CHARACTERISTICS (Note	e 3)						
Turn-On Delay Time	t _{d(ON)}				5.0	10	ns
Rise Time	t _r	V _{GS} = 4.5 V, V	חס = 16 V.		9.0	18	
Turn-Off Delay Time	t _{d(OFF)}	I _D = 2.9 A, R			10	20	
Fall Time	t _f				3.0	6.0	
DRAIN-SOURCE DIODE CHARACTER	ISTICS (Note 2)						-
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I	_S = 2.6 A		0.8	1.15	V
Reverse Recovery Time	t _{RR}				12.5		ns
Charge Time	ta	V _{GS} = 0 V, I _S	= 2.6 A,		9.0		1
Discharge Time	tb	$dl_{S}/dt = 100 \text{ A}/\mu\text{s}$			3.5		1
Reverse Recovery Charge	Q _{RR}				6.0		nC
SCHOTTKY DIODE ELECTRICAL	CHARACTERIS	TICS (T _J = 25°C un	less otherwise no	ted)	-	-	-
Parameter	Symbol	Test Cond	litions	Min	Тур	Max	Units
	- <u>,</u>			+	1		<u> </u>

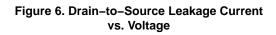
Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
Maximum Instantaneous Forward Voltage	V _F	I _F = 0.1 A			0.31	V
		I _F = 1.0 A			0.365	
Maximum Instantaneous Reverse Current	I _R	V _R = 10 V			0.75	mA
		V _R = 20 V			2.5	
Non-Repetitive Peak Surge Current	I _{FSM}	Halfwave, Single Pulse, 60 Hz			23	А

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

8 8 $V_{GS} = 5 V \text{ to } 3 V$ $T_{.1} = 25^{\circ}C$ $V_{DS} \ge 10 \text{ V}$ √_{GS} = 2.4 √ ID. DRAIN CURRENT (AMPS) I_{D,} DRAIN CURRENT (AMPS) 2 V V 6 6 1.8 V 4 4 1.6 V 2 2 $T_{C} = -55^{\circ}$ 1.4 V 25 100°C 0 0 0.5 0 2 3 4 5 7 9 10 0 2 2.5 3 6 8 1.5 1 1 V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS) V_{DS}, DRAIN-TO-SOURCE VOLTAGE (VOLTS) Figure 1. On–Region Characteristics Figure 2. Transfer Characteristics R_{DS(on)}, DRAIN-TO-SOURCE RESISTANCE (Ω) $R_{DS(on)}$, DRAIN-TO-SOURCE RESISTANCE (Ω) 0.1 0.15 I_D = 2.9 A T_J = 25°C $T_J = 25^{\circ}C$ $V_{GS} = 2.5 V$ 0.1 0.07 $V_{GS} = 4.5 V$ 0.05 0 0.04 7 2 3 5 6 3 5 0 1 4 1 V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS) ID, DRAIN CURRENT (AMPS) Figure 3. On-Resistance vs. Gate-to-Source Figure 4. On–Resistance vs. Drain Current and **Gate Voltage** Voltage 100 1.7 $I_{D} = 2.9 \text{ A}$ $V_{GS} = 0 V$ V_{GS} = 4.5 V R_{DS(on)}, DRAIN-TO-SOURCE RESISTANCE (NORMALIZED) 1.5 I_{DSS}, LEAKAGE (nA) $T_J = 100^{\circ}C$ 1.3 10 1.1 0.9 0.7 1 -50 -25 0 25 50 75 100 125 150 4 6 8 10 12 16 2 14 18 20 T_J, JUNCTION TEMPERATURE (°C) V_{DS}, DRAIN-TO-SOURCE VOLTAGE (VOLTS)

TYPICAL MOSFET PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

Figure 5. On–Resistance Variation with Temperature



TYPICAL MOSFET PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

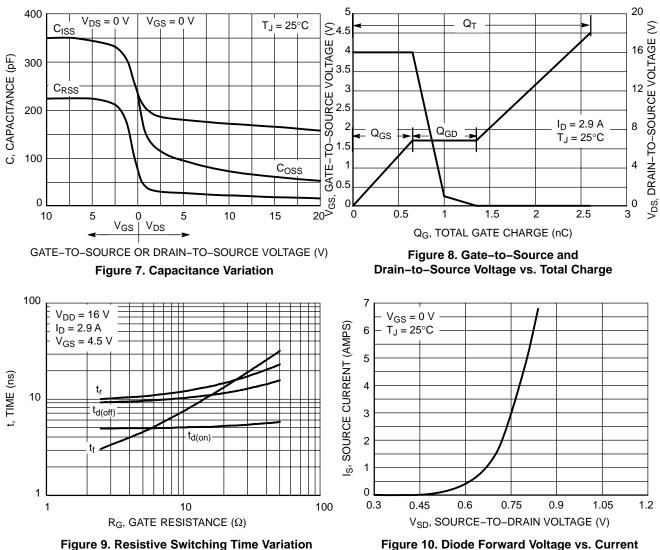
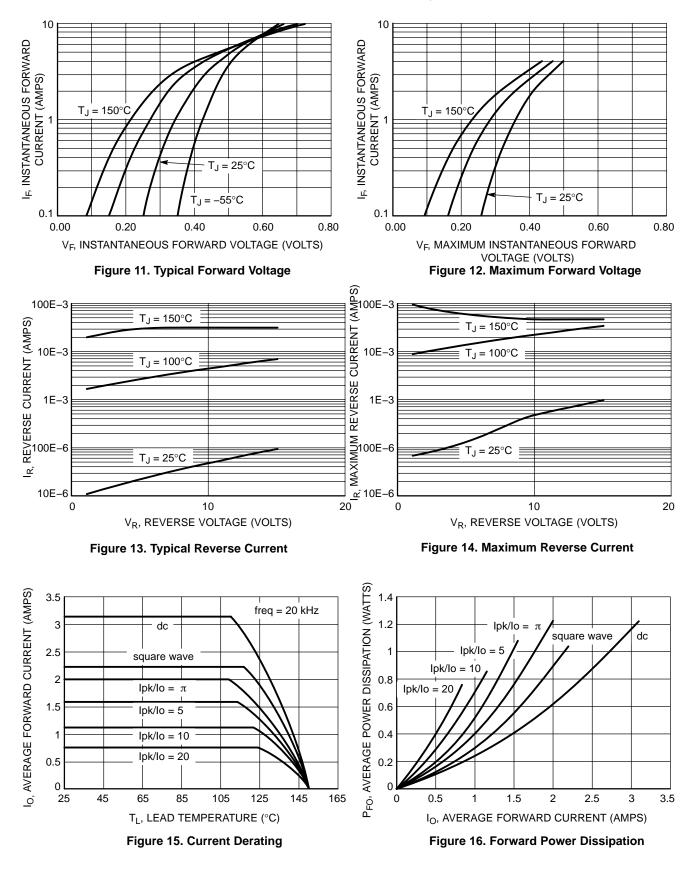


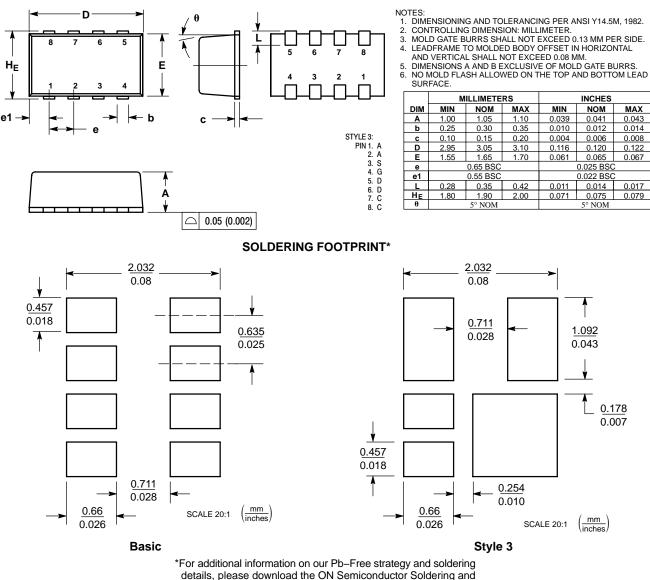
Figure 9. Resistive Switching Time Variation vs. Gate Resistance

TYPICAL SCHOTTKY PERFORMANCE CURVES (T_J = 25° C unless otherwise noted)



PACKAGE DIMENSIONS

ChipFET[™] CASE 1206A-03 **ISSUE G**



Mounting Techniques Reference Manual, SOLDERRM/D.

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